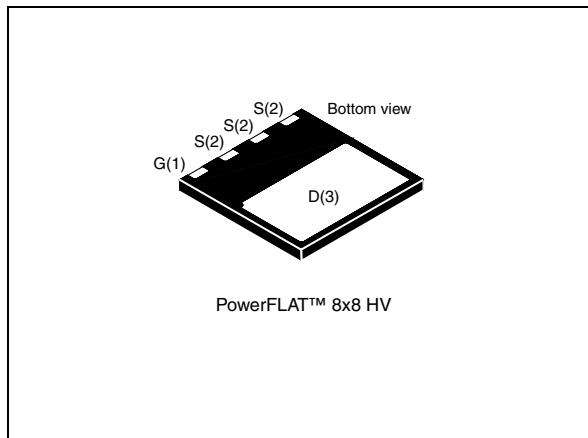
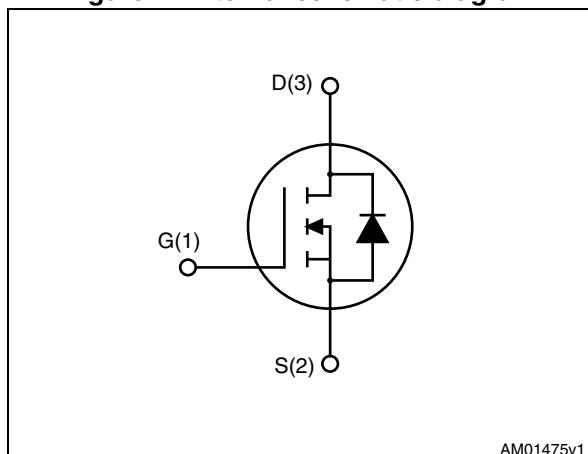


## N-channel 650 V, 0.135 $\Omega$ typ., 15 A MDmesh™ V Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data



**Figure 1. Internal schematic diagram**



AM01475v1

## Features

Order code	$V_{DS}$	$R_{DS(on)} \text{ max}$	$I_D$
STL31N65M5	710 V	0.162 $\Omega$	15 A <sup>(1)</sup>

1. The value is rated according to  $R_{thj-case}$  and limited by package.

- Worldwide best  $R_{DS(on)} * \text{area}$
- Higher  $V_{DSS}$  rating and high dv/dt capability
- Excellent switching performance

## Applications

- Switching applications

## Description

This device is an N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

**Table 1. Device summary**

Order code	Marking	Packages	Packaging
STL31N65M5	31N65M5	PowerFLAT™ 8x8 HV	Tape and reel

## Contents

<b>1</b>	<b>Electrical ratings</b>	<b>3</b>
<b>2</b>	<b>Electrical characteristics</b>	<b>4</b>
2.1	Electrical characteristics (curves)	6
<b>3</b>	<b>Test circuits</b>	<b>9</b>
<b>4</b>	<b>Package mechanical data</b>	<b>10</b>
<b>5</b>	<b>Packaging mechanical data</b>	<b>14</b>
<b>6</b>	<b>Revision history</b>	<b>16</b>

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	650	V
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	15	A
$I_D^{(1)}$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	12	A
$I_{DM}^{(1),(2)}$	Drain current (pulsed)	60	A
$I_D^{(3)}$	Drain current (continuous) at $T_{amb} = 25^\circ\text{C}$	2.8	A
$I_D^{(3)}$	Drain current (continuous) at $T_{amb} = 100^\circ\text{C}$	1.8	A
$P_{TOT}^{(3)}$	Total dissipation at $T_{amb} = 25^\circ\text{C}$	2.8	W
$P_{TOT}^{(1)}$	Total dissipation at $T_C = 25^\circ\text{C}$	125	W
$I_{AR}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	5	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{ V}$ )	410	mJ
$dv/dt^{(4)}$	Peak diode recovery voltage slope	15	V/ns
$T_{stg}$	Storage temperature	- 55 to 150	$^\circ\text{C}$
$T_j$	Max. operating junction temperature	150	$^\circ\text{C}$

1. The value is rated according to  $R_{thj-case}$  and limited by package.
2. Pulse width limited by safe operating area.
3. When mounted on FR-4 board of inch<sup>2</sup>, 2oz Cu.
4.  $I_{SD} \leq 15\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ,  $V_{DD} = 400\text{ V}$ ,  $V_{DS(\text{peak})} < V_{(BR)DSS}$ .

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	1	$^\circ\text{C}/\text{W}$
$R_{thj-amb}^{(1)}$	Thermal resistance junction-ambient max	45	$^\circ\text{C}/\text{W}$

1. When mounted on FR-4 board of inch<sup>2</sup>, 2oz Cu.

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified)

**Table 4. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	650			V
$I_{\text{DSS}}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 650 \text{ V}$			1	$\mu\text{A}$
		$V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$			100	$\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 25 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 11 \text{ A}$		0.135	0.162	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$	-	1865	-	pF
$C_{oss}$	Output capacitance		-	45	-	pF
$C_{rss}$	Reverse transfer capacitance		-	4	-	pF
$C_{o(er)}^{(1)}$	Equivalent output capacitance energy related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 80\% V_{(\text{BR})\text{DSS}}$	-	43	-	pF
$C_{o(tr)}^{(2)}$	Equivalent output capacitance time related		-	146	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz open drain}$	-	2.8	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 11 \text{ A}, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 16</a> )	-	45	-	nC
$Q_{gs}$	Gate-source charge		-	11.5	-	nC
$Q_{gd}$	Gate-drain charge		-	20	-	nC

1. Energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$
2. Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_d(v)$	Voltage delay time	$V_{DD} = 400 \text{ V}$ , $I_D = 14 \text{ A}$ , $R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 20</a> )	-	46	-	ns
$t_r(v)$	Voltage rise time		-	8	-	ns
$t_f(i)$	Current fall time		-	8.5	-	ns
$t_c(\text{off})$	Crossing time		-	11	-	ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)}$	Source-drain current		-		15	A
$I_{SDM}^{(1),(2)}$	Source-drain current (pulsed)		-		60	A
$V_{SD}^{(3)}$	Forward on voltage	$I_{SD} = 15 \text{ A}$ , $V_{GS} = 0$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 15 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$ (see <a href="#">Figure 17</a> )	-	290		ns
$Q_{rr}$	Reverse recovery charge		-	4		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	27		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 15 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$ , $T_j = 150^\circ\text{C}$ (see <a href="#">Figure 17</a> )	-	340		ns
$Q_{rr}$	Reverse recovery charge		-	5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	29		A

1. The value is rated according to  $R_{thj-case}$  and limited by package.
2. Pulse width limited by safe operating area
3. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

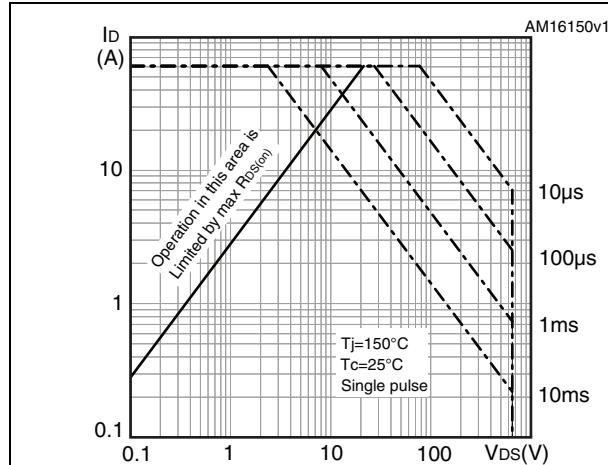


Figure 3. Thermal impedance

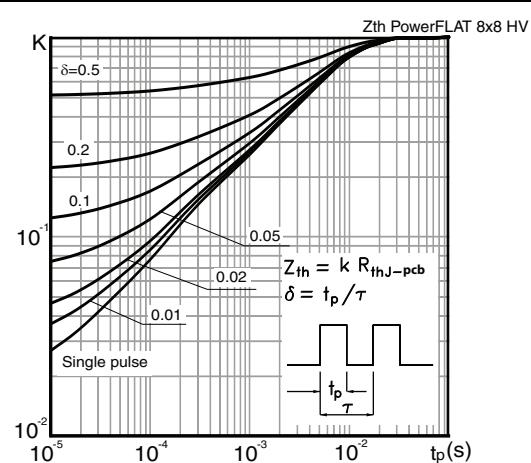


Figure 4. Output characteristics

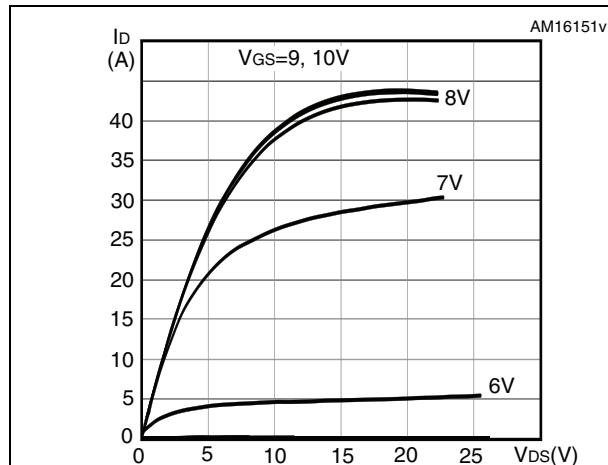


Figure 5. Transfer characteristics

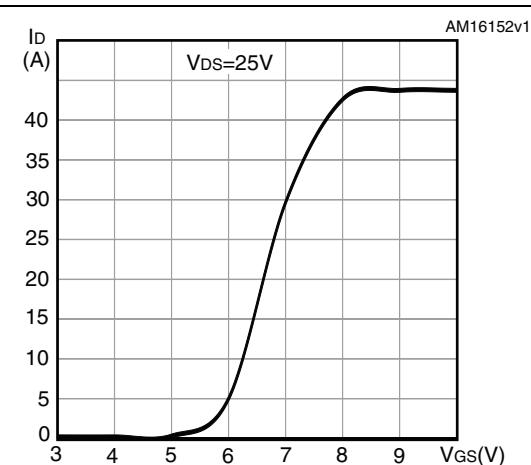


Figure 6. Gate charge vs gate-source voltage

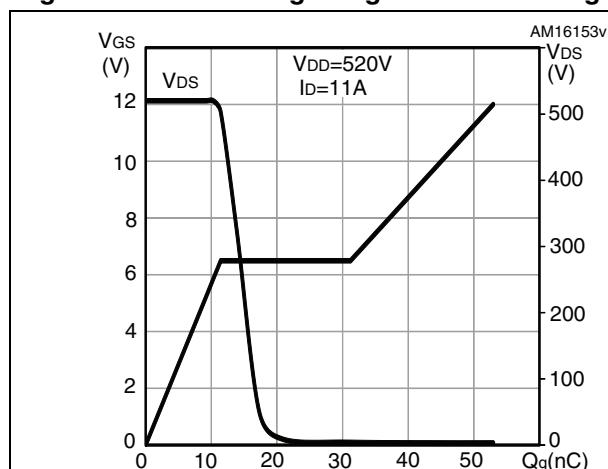
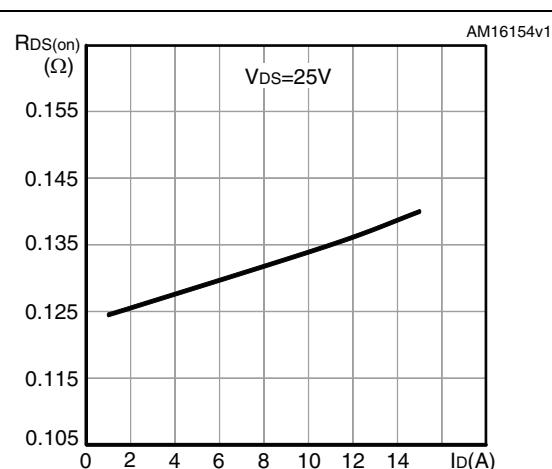
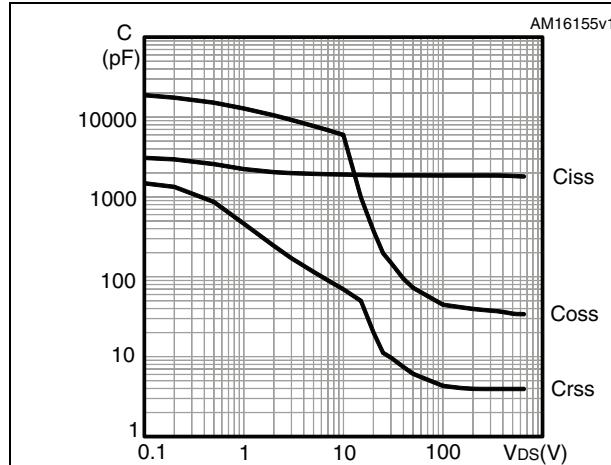
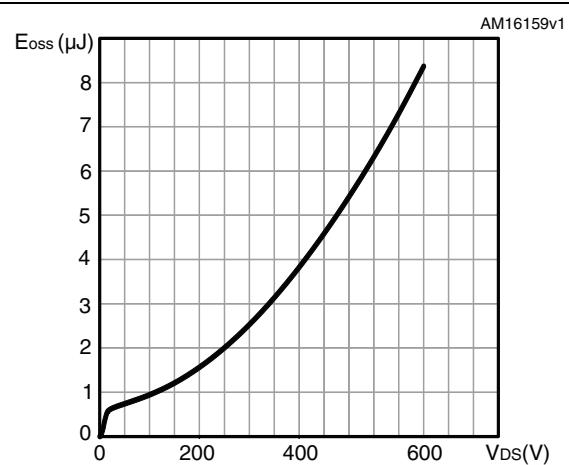
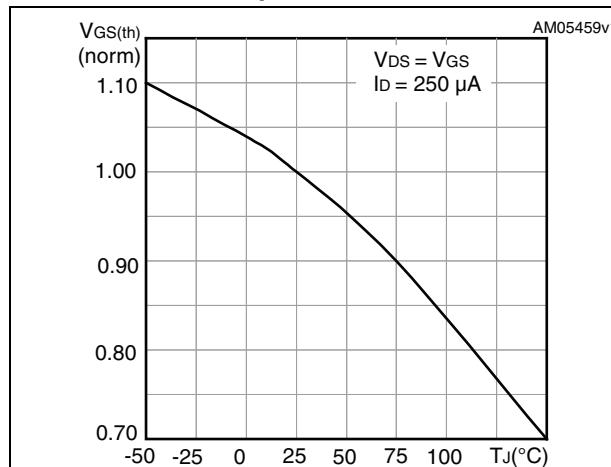
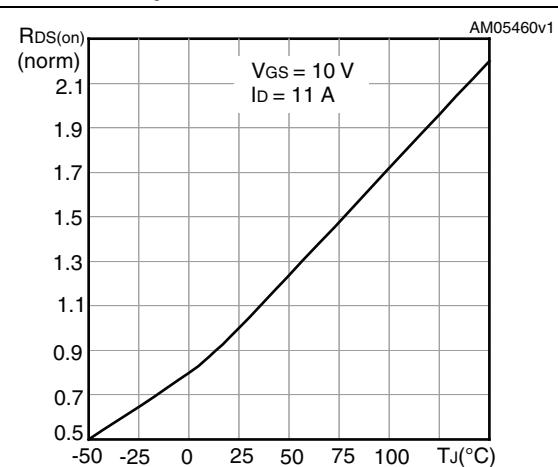
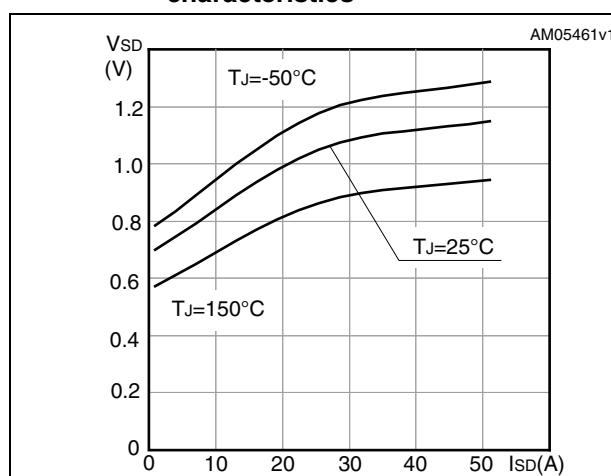
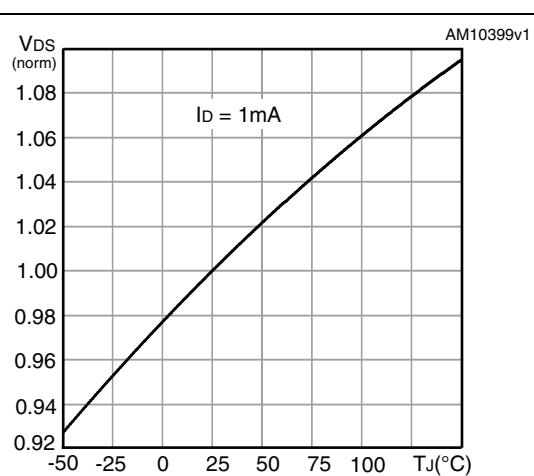
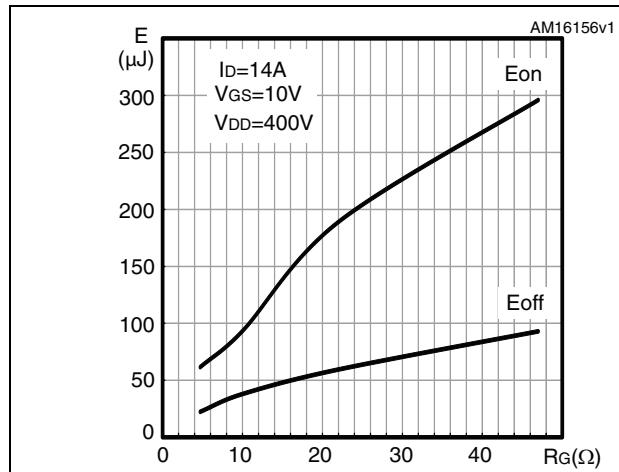


Figure 7. Static drain-source on-resistance



**Figure 8. Capacitance variations****Figure 9. Output capacitance stored energy****Figure 10. Normalized gate threshold voltage vs. temperature****Figure 11. Normalized on-resistance vs. temperature****Figure 12. Drain-source diode forward characteristics****Figure 13. Normalized V<sub>DS</sub> vs. temperature**

**Figure 14. Switching losses vs. gate resistance<sup>(1)</sup>**



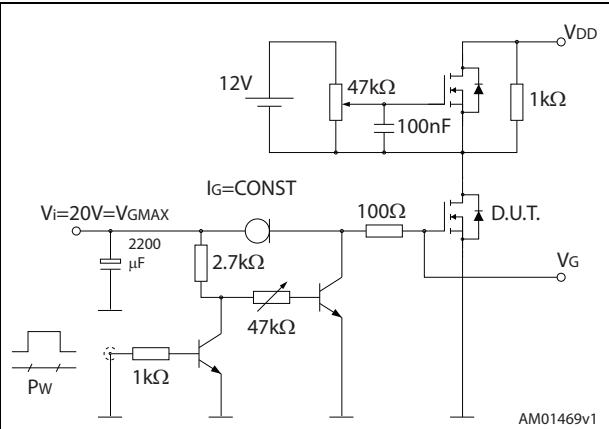
1.  $E_{on}$  including reverse recovery of a SiC diode

### 3 Test circuits

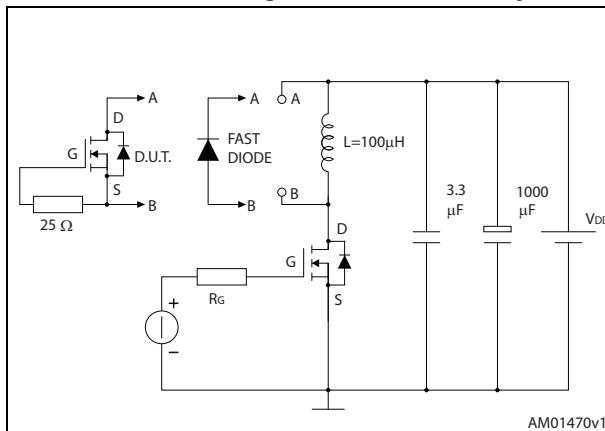
**Figure 15. Switching times test circuit for resistive load**



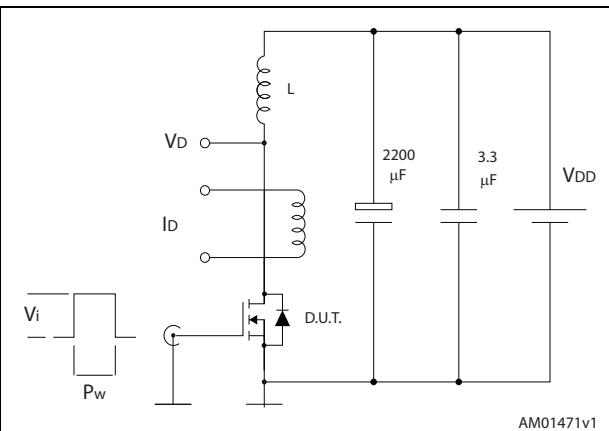
**Figure 16. Gate charge test circuit**



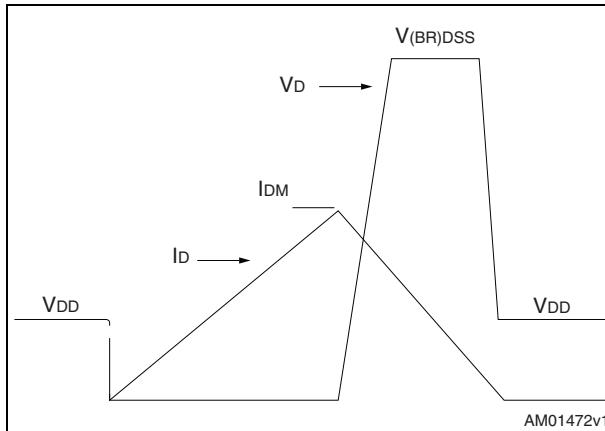
**Figure 17. Test circuit for inductive load switching and diode recovery times**



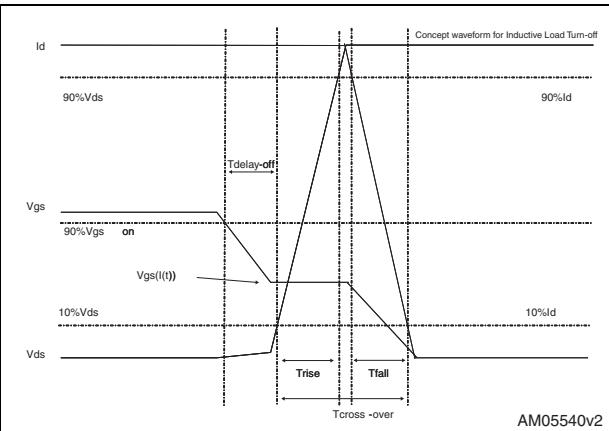
**Figure 18. Unclamped inductive load test circuit**



**Figure 19. Unclamped inductive waveform**



**Figure 20. Switching time waveform**

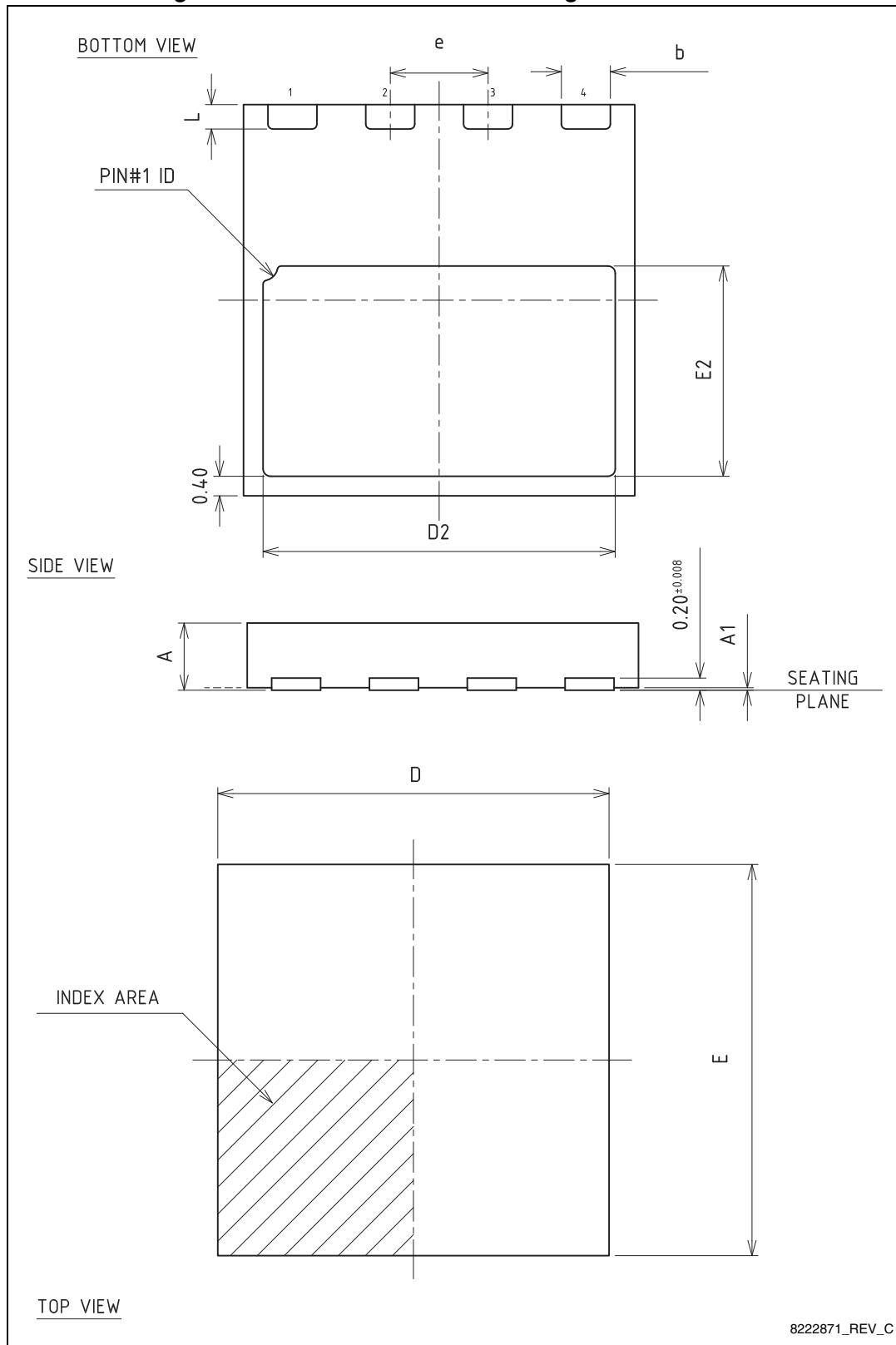


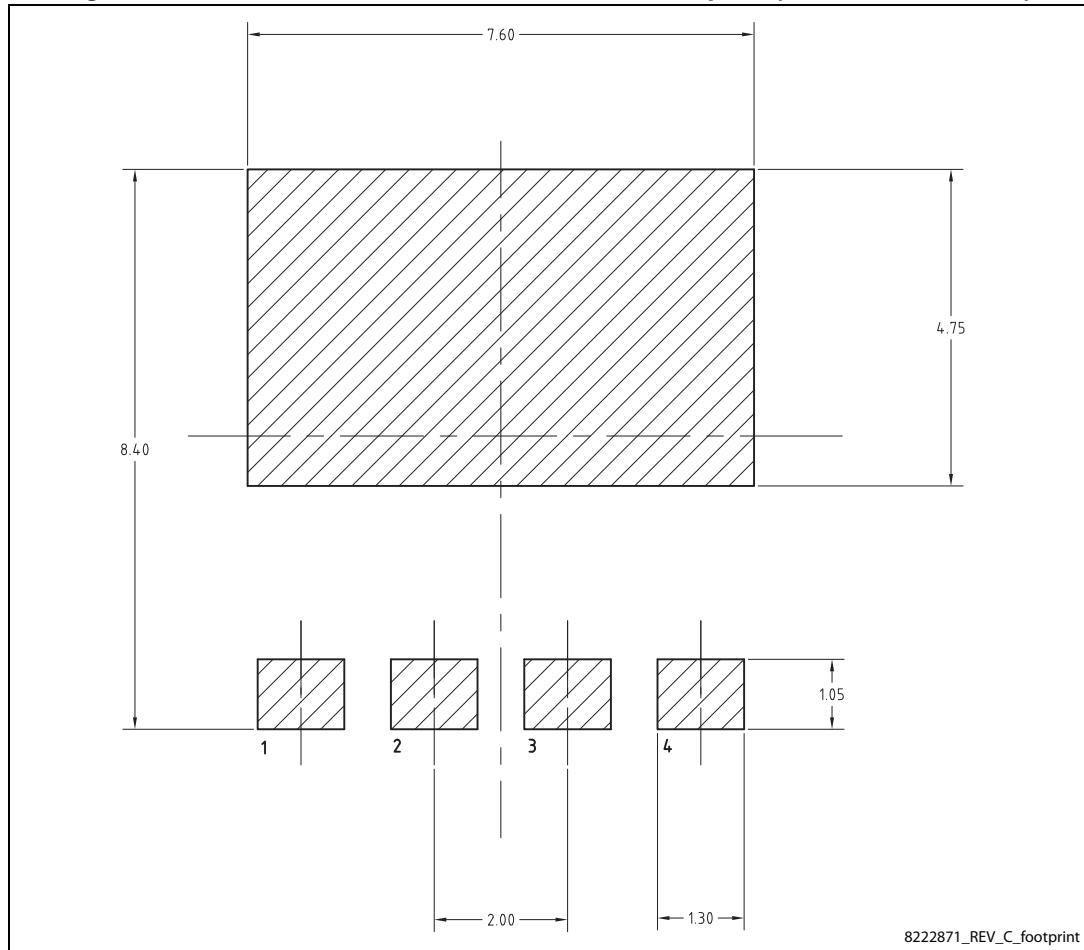
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

**Table 8. PowerFLAT™ 8x8 HV mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	0.80	0.90	1.00
A1	0.00	0.02	0.05
b	0.95	1.00	1.05
D		8.00	
E		8.00	
D2	7.05	7.20	7.30
E2	4.15	4.30	4.40
e		2.00	
L	0.40	0.50	0.60

**Figure 21. PowerFLAT™ 8x8 HV drawing mechanical data**

**Figure 22. PowerFLAT™ 8x8 HV recommended footprint (dimensions in mm.)**

## 5 Packaging mechanical data

Figure 23. PowerFLAT™ 8x8 HV tape

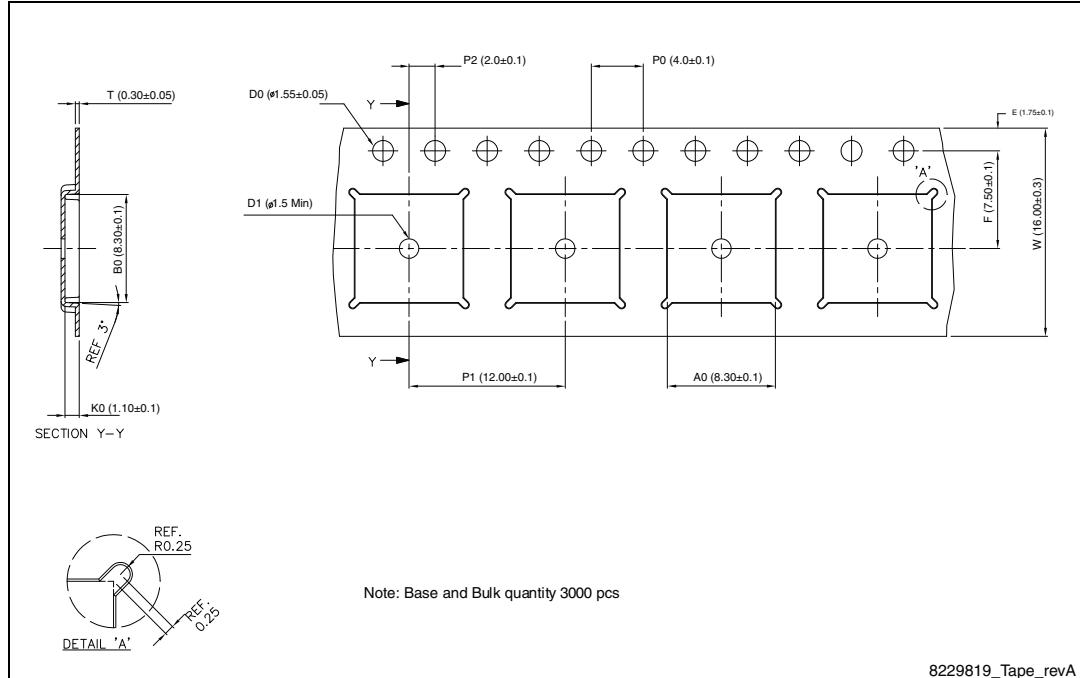
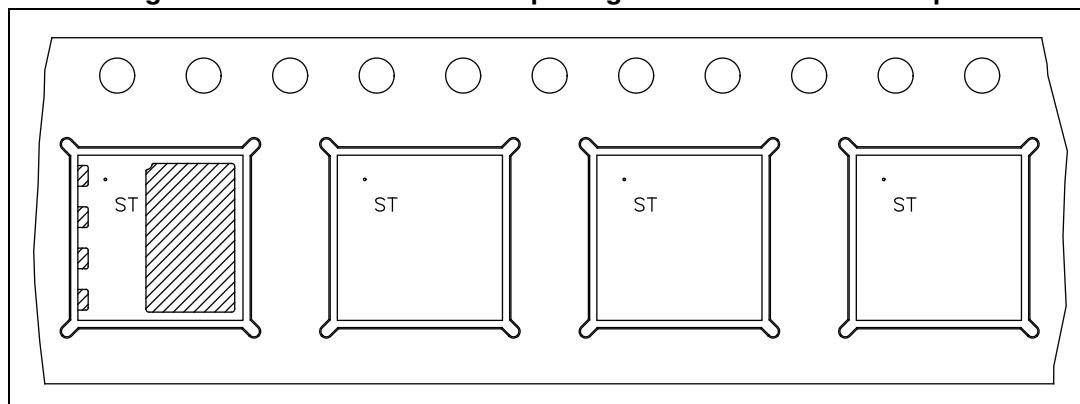
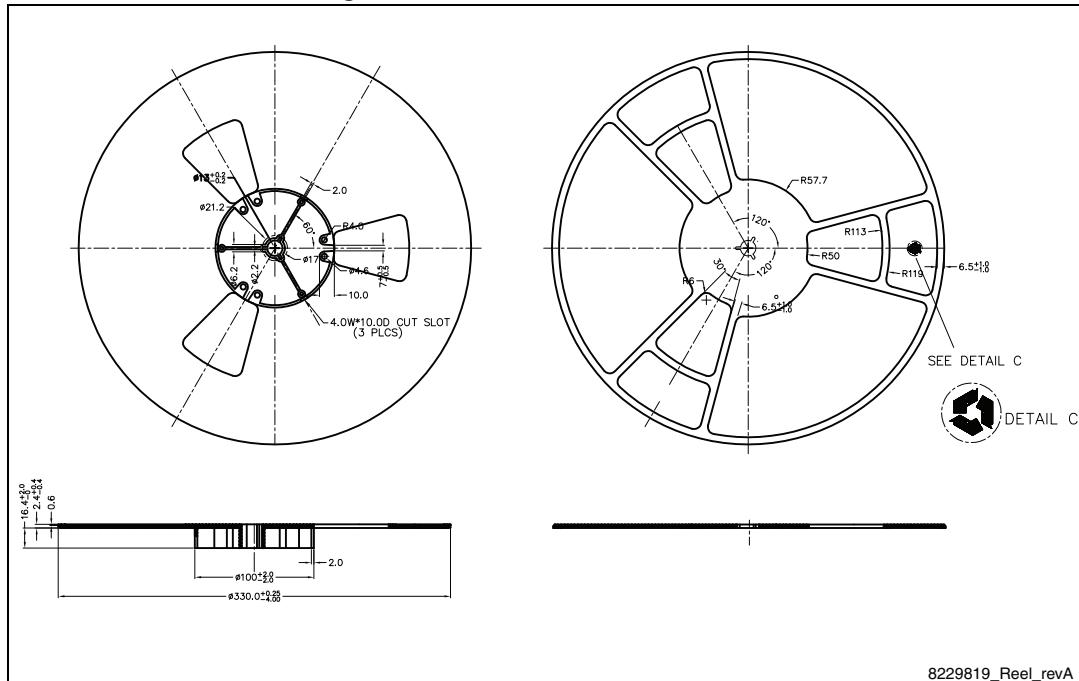


Figure 24. PowerFLAT™ 8x8 HV package orientation in carrier tape.



**Figure 25. PowerFLAT™ 8x8 HV reel**

## 6 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
31-Oct-2013	1	First release.

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